Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination
09/522 118	HAM ET AI

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Examiner

Jennifer A. Leung

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Class	Subclass	Date	Examiner		
	updated search in:				
422	218	1/16/2007	JAL		
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INTERFERENCE SEARCHED				
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422/218,22	20,311.ccls.	1/16/2007	JAL	

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
updated search, text only, see attached EAST search history.	1/16/2007	JAL
updated inventor search.	1/16/2007	JAL